# Asymptotic distribution of least square estimators for linear models with dependent errors

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### Introduction

**Estimation of the covariance matrix** 

We consider the Linear Regression Model:

 $Y = X\beta + \varepsilon,$ 

• X:  $n \times p$  fixed design matrix,

•  $\epsilon$ : strictly stationary process with zero mean.

The autocovariance function  $\gamma$  of the process  $\epsilon$  and its spectral density f satisfy:

$$\gamma(k) = \operatorname{Cov}(\varepsilon_{\mathfrak{m}}, \varepsilon_{\mathfrak{m}+k}) = \mathbb{E}(\varepsilon_{\mathfrak{m}}\varepsilon_{\mathfrak{m}+k}) = \int_{-\pi}^{\pi} e^{ik\lambda} f(\lambda) d\lambda$$

## Hannan's Central Limit Theorem

Hannan's condition on the error process:

$$\sum_{i\in\mathbb{Z}} \|P_0(\varepsilon_i)\|_{\mathbb{L}^2} < +\infty,$$

where  $P_j(Z) = \mathbb{E}(Z|\mathcal{F}_j) - \mathbb{E}(Z|\mathcal{F}_{j-1})$ . This implies that:

$$\sum_{\mathrm{k}\in\mathbb{Z}}|\gamma(\mathrm{k})|<\infty.$$

Consider the following estimator of the spectral density, for  $\lambda$  in  $[-\pi, \pi]$ :

$$f_{n}^{*}(\lambda) = \frac{1}{2\pi} \sum_{|k| \leq n-1} K\left(\frac{|k|}{c_{n}}\right) \hat{\gamma}_{k}^{*} e^{ik\lambda},$$

where:

$$\hat{\gamma}_k^* = \frac{1}{n} \sum_{j=1}^{n-|k|} \hat{\varepsilon}_j \hat{\varepsilon}_{j+|k|}, \qquad 0 \le |k| \le (n-1),$$

with  $\hat{\epsilon}$  the residuals:  $\hat{\epsilon} = Y - X\hat{\beta}$ . The kernel K is defined by:

$$\mathsf{K}(x) = \mathbbm{1}_{|x| \le 1} + (2 - |x|) \mathbbm{1}_{1 \le |x| \le 2},$$

and the sequence of positive integers  $c_n$  is such that  $c_n \xrightarrow[n \to \infty]{} \infty$  and  $\frac{c_n}{n} \xrightarrow[n \to \infty]{} 0$ .

Theorem (Consistence [1])

Let  $c_n$  be a sequence of positive integers such that  $c_n \xrightarrow[n \to \infty]{} \infty$ , and:

$$c_{n}\mathbb{E}\left(\left|\epsilon_{0}\right|^{2}\left(1\wedge\frac{c_{n}}{n}\left|\epsilon_{0}\right|^{2}\right)\right)\xrightarrow[n\to\infty]{}0.$$

Hannan's condition is satisfied for most short-range dependent stationary processes.

Let us define:  $d_j(n) = \|X_{.,j}\|_2 = \sqrt{\sum_{i=1}^n x_{i,j}^2}$ . Hannan's assumptions on the design,  $\forall j \in \{1, \dots, p\}$ :

•  $\lim_{n\to\infty} d_j(n) = \infty$ ,

• 
$$\lim_{n\to\infty} \frac{\sup_{1\leq i\leq n} |x_{i,j}|}{d_j(n)} = 0$$

• the following limits exist:  $\rho_{j,l}(k) = \lim_{n \to \infty} \sum_{m=1}^{n-k} \frac{x_{m,j} x_{m+k,l}}{d_j(n) d_l(n)}$ .

Let R(k) be the matrice:

$$\mathbf{R}(\mathbf{k}) = [\rho_{\mathbf{j},\mathbf{l}}(\mathbf{k})] = \int_{-\pi}^{\pi} e^{\mathbf{i}\mathbf{k}\lambda} \mathbf{F}_{\mathbf{X}}(\mathbf{d}\lambda);$$

with  $F_X$  the spectral measure associated with the matrix R(k). Moreover R(0) is supposed to be positive definite. Let then F and G be the matrices:

$$F = \frac{1}{2\pi} \int_{-\pi}^{\pi} F_X(d\lambda), \qquad G = \frac{1}{2\pi} \int_{-\pi}^{\pi} F_X(d\lambda) \otimes f(\lambda).$$

#### Theorem (Hannan's theorem [2])

Under the previous conditions, we have:

$$\begin{split} \mathsf{D}(\mathfrak{n})(\widehat{\beta}-\beta) \xrightarrow[\mathfrak{n}\to\infty]{} \mathcal{N}(0,\mathsf{F}^{-1}\mathsf{G}\mathsf{F}^{-1}),\\ \mathbb{E}\left(\mathsf{D}(\mathfrak{n})(\widehat{\beta}-\beta)(\widehat{\beta}-\beta)^{\mathsf{t}}\mathsf{D}(\mathfrak{n})^{\mathsf{t}}\right) \xrightarrow[\mathfrak{n}\to\infty]{} \mathsf{F}^{-1}\mathsf{G}\mathsf{F}^{-1}. \end{split}$$

## **Regular design**

Hannan's theorem is very general because it includes a very large class of designs:

Definition (Regular design)

A fixed design X is called regular if, for any j,l in  $\{1, \ldots, p\}$ , the coefficients  $\rho_{j,l}(k)$  do not depend on k.

A large class of regular designs: the regularly varying sequences (i.e. of the form  $S(i) = i^{\alpha}L(i)$ , where  $\alpha \in \mathbb{R}$  and  $L(\cdot)$  a slowly varying sequence).

For regular design, the asymptotic covariance matrix is easy to compute.

### Corollary (Hannan's theorem with regular design)

Then, under the assumptions of Hannan's theorem:

$$\sup_{\lambda\in[-\pi,\pi]}\left\|f_{n}^{*}(\lambda)-f(\lambda)\right\|_{\mathbb{L}^{1}}\xrightarrow[n\to\infty]{}0.$$

Combining Hannan's theorem and the previous result, we get:

#### Corollary

*If* f(0) > 0*, then:* 

$$\frac{\mathsf{R}(0)^{\frac{1}{2}}}{\sqrt{2\pi f_{\mathfrak{n}}^{*}(0)}}\mathsf{D}(\mathfrak{n})(\widehat{\beta}-\beta) \xrightarrow[\mathfrak{n}\to\infty]{\mathcal{L}} \mathcal{N}(0,\mathrm{I}_{\mathfrak{p}}),$$

where  $I_p$  is the  $p \times p$  identity matrix.

## Tests

Thanks to these results, the usual Fischer tests on the linear model can be adapted to the case where the errors are short-range dependent. As usual, the null hypothesis  $H_0$  means that the parameter  $\beta$  belongs to a vector space with dimension equal to  $p_0$  (strictly smaller than p), and we denote by  $H_1$  the alternative hypothesis.

Recall that if the errors are i.i.d. Gaussian random variables, the test statistic is:

$$F = \frac{1}{p - p_0} \times \frac{RSS_0 - RSS}{\hat{\sigma}_{\epsilon}^2},$$

where  $RSS = \|\hat{\varepsilon}\|_2^2$ ,  $RSS_0 = \|\hat{\varepsilon}_{H_0}\|_2^2$  and  $\hat{\sigma}_{\varepsilon}^2 = \frac{RSS}{n-p}$ . Under  $H_0$ ,  $F \sim \mathcal{F}_{n-p}^{p-p_0}$ . If the error process  $(\varepsilon_i)_{i \in \mathbb{Z}}$  is stationary, the test statistic must be corrected as follows:

$$\tilde{F}_{c} = \frac{1}{p - p_{0}} \times \frac{RSS_{0} - RSS}{2\pi f_{n}^{*}(0)}.$$

It converges to a  $\chi^2$ -distribution with parameter  $p - p_0$ .

## Simulations

Let us simulate the process  $(\varepsilon_i)_{1 \le i \le n}$  according to the AR(1) equation:

$$\varepsilon_{k+1} = \frac{1}{2}(\varepsilon_k + \eta_{k+1}),$$

where  $\epsilon_1$  is uniformly distributed over  $[-\frac{1}{2}, \frac{1}{2}]$ , and  $(\eta_i)_{i\geq 2}$  is a sequence of i.i.d. random variables, independent of  $\epsilon_1$ , such that  $\mathbb{P}(\eta_i = -\frac{1}{2}) = \mathbb{P}(\eta_i = \frac{1}{2}) = \frac{1}{2}$ .

Under the assumptions of Hannan's Theorem, if moreover the design X is regular, then:

$$\mathsf{D}(\mathfrak{n})(\widehat{\beta}-\beta) \xrightarrow[\mathfrak{n}\to\infty]{\mathcal{L}} \mathcal{N}\left(0,\left(\sum_{k=-\infty}^{\infty}\gamma(k)\right)\mathsf{R}(0)^{-1}\right),$$

and we have the convergence of the second order moment:

$$\mathbb{E}\left(\mathsf{D}(\mathfrak{n})(\widehat{\beta}-\beta)(\widehat{\beta}-\beta)^{\mathsf{t}}\mathsf{D}(\mathfrak{n})^{\mathsf{t}}\right)\xrightarrow[\mathfrak{n}\to\infty]{}\left(\sum_{k=-\infty}^{\infty}\gamma(k)\right)\mathsf{R}(\mathfrak{0})^{-1}.$$

In the case of regular design, the asymptotic covariance matrix is similar to the one in the case where the random variables ( $\epsilon_i$ ) are i.i.d.; the variance term  $\sigma^2$  is replaced by the series of covariances.

Thus, to obtain confidence regions and tests for the parameter  $\beta$ , an estimator of:  $\sum_{k=-\infty}^{\infty} \gamma(k)$  is needed.

The model simulated with this error process is,  $\forall i \in \{1, ..., n\}$ :

 $Y_{i} = \beta_{0} + \beta_{1}\sqrt{i} + \beta_{2}\log(i) + 10\varepsilon_{i}.$ 

We test H<sub>0</sub>:  $\beta_1 = \beta_2 = 0$  against H<sub>1</sub>:  $\beta_1 \neq 0$  or  $\beta_2 \neq 0$ , and we want an estimated level close to 5%.

• Case  $\beta_1 = \beta_2 = 0$ , no correction:

n	500	1000	2000	3000	4000	5000
Estimated level	0.4435	0.4415	0.427	0.3925	0.397	0.4075

• Case  $\beta_1 = \beta_2 = 0$ , with correction:

n	500	1000	2000	3000	4000	5000
Estimated level	0.106	0.1	0.078	0.072	0.077	0.068

If one increases the size of the samples n, we are getting closer to the estimated level 5%.

#### References

#### [1] E. Caron and S. Dede.

Asymptotic distribution of least square estimators for linear models with dependent errors : regular designs. working paper or preprint, Oct. 2017.

[2] E. J. Hannan.

Central limit theorems for time series regression. Probability theory and related fields, 26(2):157–170, 1973.